SN54ACT16244, 74ACT16244 16-BIT BUFFERS/LINE DRIVERS WITH 3-STATE OUTPUTS SCAS116B – MARCH 1990 – REVISED APRIL 1996

SN54ACT16244 . . . WD PACKAGE **Members of the Texas Instruments** 74ACT16244 . . . DGG OR DL PACKAGE Widebus[™] Family (TOP VIEW) Inputs Are TTL-Voltage Compatible 48 20E 3-State Outputs Drive Bus Lines or Buffer 1 OE Memory Address Registers 1Y1 🛛 2 47 1 1A1 1Y2 🛛 3 46 1A2 Flow-Through Architecture Optimizes 45 [] GND GND 4 **PCB** Layout 1Y3 **[**5 44 🛛 1A3 Distributed V_{CC} and GND Pin 43 1A4 1Y4 6 **Configurations Minimize High-Speed** V_{CC} []7 42 VCC Switching Noise 2Y1 8 41 2A1 **EPIC[™]** (Enhanced-Performance Implanted 2Y2 🛛 9 40 **2**A2 CMOS) 1-um Process 39 GND GND 10 500-mA Typical Latch-Up Immunity at 2Y3 11 38 2A3 125°C 37 2A4 2Y4 112 • **Package Options Include Plastic Shrink** 36 🛛 3A1 3Y1 113 Small-Outline (DL) and Thin Shrink 35 3A2 3Y2 114 Small-Outline (DGG) Packages, and 380-mil GND 115 34 GND Fine-Pitch Ceramic Flat (WD) Packages 33 3A3 3Y3 16 Using 25-mil Center-to-Center Pin Spacings 32 3A4 3Y4 117 V_{CC} []18 31 V_{CC} description 4Y1 🛛 19 30 4A1 AVA DAS ~h 440 The SN54ACT16244 and 74ACT16244 7

The SN54ACT16244 and 74ACT16244 are 16-bit buffers/line drivers designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. They can be used as four 4-bit buffers, two 8-bit buffers, or one 16-bit buffer. The devices provide true outputs and symmetrical \overline{OE} (active-low) output-enable inputs.

4 are 16-bit	4Y2 L 20	29 🛛 4A2
cifically to	GND 21	28 GND
density of	4Y3 🛛 22	27 🛛 4A3
ck drivers,	4Y4 [23	26 🛛 4A4
ansmitters.	4 0E [24	25 3OE
s, two 8-bit		
es provide		
active-low)		

The 74ACT16244 is packaged in TI's shrink small-outline package, which provides twice the I/O pin count and functionality of standard small-outline packages in the same printed-circuit-board area.

The SN54ACT16244 is characterized for operation over the full military temperature range of –55°C to 125°C. The 74ACT16244 is characterized for operation from –40°C to 85°C.

(each driver)								
INP	UTS	OUTPUT						
OE	Α	Y						
L	Н	Н						
L	L	L						
н	Х	Z						

FUNCTION TABLE (each driver)



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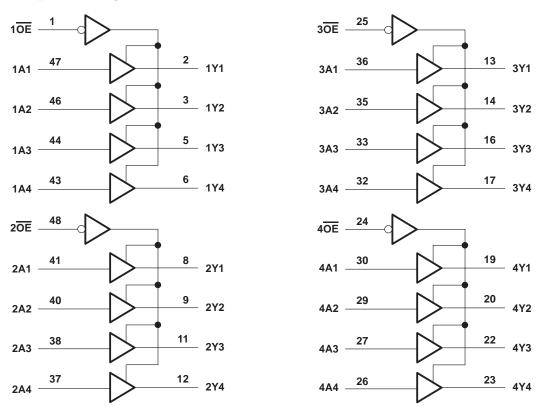
logic symbol[†]

					1	
1 <mark>0E</mark>	1	EN1				
2 <mark>0E</mark>	48	EN2				
3 <mark>0E</mark>	25	EN3				
4 <u>0</u> E	24	EN4				
40L		Ľ"*				
1A1	47	┎┖━━	1	1▽	2	1Y1
1A2	46	<u> </u>	-	- •	3	1Y2
1A3	44	<u> </u>			5	1Y3
1A4	43	<u> </u>			6	1Y4
2A1	41	<u> </u>	1	2 ▽	8	2Y1
2A2	40			- •	9	2Y2
2A2	38	<u> </u>			11	212 2Y3
	37				12	
2A4	36	<u> </u>	1	3 ▽	13	2Y4
3A1	35	 	1	ა∨ 	14	3Y1
3A2	33	 			16	3Y2
3A3	32				17	3Y3
3A4	30	 		4	19	3Y4
4A1	29		1	4 ▽	20	4Y1
4A2	27	 			22	4Y2
4A3	26	 			23	4Y3
4A4						4Y4

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V _I (see Note 1)	–0.5 V to V _{CC} + 0.5 V
Output voltage range, V _O (see Note 1)	–0.5 V to V _{CC} + 0.5 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I_{OK} (V _O < 0 or V _O > V _{CC})	±50 mA
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V _{CC} or GND	±400 mA
Maximum power dissipation at $T_A = 55^{\circ}C$ (in still air) (see Note 2): DGG packag	e0.85 W
DL package	1.2 W
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.



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recommended operating conditions (see Note 3)

		SN54ACT16244		44 74ACT16244		UNIT
		MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage (see Note 4)	4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2		2		V
VIL	Low-level input voltage		0.8		0.8	V
VI	Input voltage	0	VCC	0	VCC	V
Vo	Output voltage	0	VCC	0	VCC	V
ЮН	High-level output current		-24		-24	mA
IOL	Low-level output current		24		24	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	0	10	0	10	ns/V
т _А	Operating free-air temperature	-55	125	-40	85	°C

NOTES: 3. Unused inputs should be tied to V_{CC} through a pullup resistor of approximately 5 k Ω or greater to prevent them from floating.

4. All V_{CC} and GND pins must be connected to the proper voltage supply.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	TEST CONDITIONS	N	T,	₄ = 25°C	;	SN54AC	Г16244	74ACT16244		UNIT
PARAMETER	TEST CONDITIONS	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
	1	4.5 V	4.4			4.4		4.4		
	I _{OH} = -50 μA	5.5 V	5.4			5.4		5.4		
Vou		4.5 V	3.94			3.7		3.8		V
VOH	I _{OH} = -24 mA	5.5 V	4.94			4.7		4.8		v
	$I_{OH} = -50 \text{ mA}^{\dagger}$	5.5 V				3.85				
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V						3.85		
	I _{OL} = 50 μA	4.5 V			0.1		0.1		0.1	V
		5.5 V			0.1		0.1		0.1	
Ve	I _{OL} = 24 mA	4.5 V			0.36		0.5		0.44	
VOL		5.5 V			0.36		0.5		0.44	
	$I_{OL} = 50 \text{ mA}^{\dagger}$	5.5 V					1.65			
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V							1.65	
Ц	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1		±1	μΑ
I _{OZ}	$V_{O} = V_{CC}$ or GND	5.5 V			±0.5		±10		±5	μΑ
ICC	$V_{I} = V_{CC} \text{ or GND}, I_{O} = 0$	5.5 V			8		160		80	μΑ
ΔI_{CC}^{\ddagger}	One input at 3.4 V, Other inputs at GND or V _{CC}	5.5 V			0.9		1		1	mA
Ci	$V_I = V_{CC}$ or GND	5 V		4.5						pF
Co	$V_{O} = V_{CC} \text{ or } GND$	5 V		13.5						pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

[‡]This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V_{CC}.



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switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

				SN5	4ACT16	244		
PARAMETER	FROM (INPUT)	TO (OUTPUT)	Т	ן = 25°C		MIN	MAV	UNIT
	(111 01)	(001101)	MIN	TYP MAX MIN MAX				
^t PLH	٨	V	4	6.5	8.5	3	10.3	20
^t PHL	A	T	3.4	6.3	8.7	3.4	10.1	ns
^t PZH	ŌĒ	V	3	5.8	8.1	3	10.5	20
tPZL		T	3.7	6.7	9.3	3.7	11	ns
^t PHZ	OE	V	5.4	8.1	11.5	5.4	13	ns
tPLZ	UE	I	5	7.5	9.5	5	10.9	115

switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

				74/	ACT162	44					
PARAMETER	FROM (INPUT)	$T_{\Delta} = 25^{\circ}C$		T _A = 25°C MIN MA				TO $T_A = 25^{\circ}C$ MIN		MAY	UNIT
	(INI 01)	(001101)	MIN	TYP	MAX	IVIIIN	WAA				
^t PLH	٨	V	4	6.5	8.5	4	9.4	ns			
^t PHL	A	T	3.4	6.3	8.7	3.4	9.5	115			
^t PZH	ŌĒ	V	3	5.8	8.1	3	8.9	ns			
^t PZL		Ι	3.7	6.7	9.3	3.7	10.3	115			
^t PHZ	OE	V	5.4	8.1	10.3	5.4	11.3	ns			
tPLZ	UE		5	7.5	9.5	5	10.3	115			

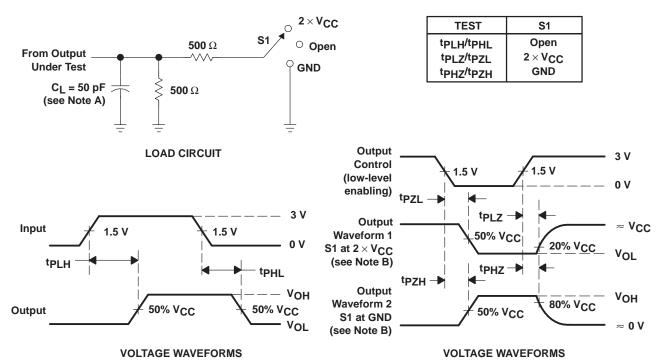
operating characteristics, $V_{CC} = 5 V$, $T_A = 25^{\circ}C$

PARAMETER			TEST CO	TYP	UNIT
C _{pd} Power dissipation capacitance	Outputs enabled	C ₁ = 50 pF. f = 1 MHz		39	ъE
	Power dissipation capacitance	Outputs disabled	C _L = 50 pF,	t = 1 MHz	11



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PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.

- Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_r = 3 ns, t_f = 3 ns.

D. The outputs are measured one at a time with one input transition per measurement.





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